

**Search Notes**

Application/Control No.

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Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

SUBIRADA ET AL.

Art Unit

2861 •

**SEARCHED**

Class	Subclass	Date	Examiner
347	5, 15-16, 19	11/19/2005	HP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
347	19	11/19/2005	HP
PGPub Text Search		11/19/2005	HP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	11/19/2005	HP